

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
208674US0SERIAL NO.
NEW APPLICATION

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Tatsumi HIRAMOTO, et al.

FILING DATE

HEREWITH

GROUP

Page 68 U.S. PTO
FILING DATE 09/19/85
5688

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	IF APPROPRIATE
<i>DA</i>	AA	4,556,057	12/03/85	Teruo HIRUMA, et al.			
<i>DA</i>	AB	5,643,334	07/01/97	Shimon ECKHOUSE, et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
<i>DA</i>	AO	7-59783	03/07/95	JAPAN (with English Abstract)	<i>ABST</i>	X
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

Examiner

[Signature]

Date Considered

September 19, 2002

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 208674US0		SERIAL NO. 09/855,688	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Tatsumi HIRAMOTO, et al.			
				FILING DATE May 16, 2001		GROUP 3762	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	RECEIVED IF APPROPRIATE
<i>W</i>	AA	3,958,145	05/18/76	A. G. JACK, et al.			APR 10 2002
	AB						
	AC						
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	AM						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>W</i>	AO	WO 93/18541	09/16/93	WIPO			
<i>W</i>	AP	0 360 326	03/28/90	EUROPE			
	AQ						
	AR						
	AS						
	AT						
	AU						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
<i>W</i>	AV	Patent Abstracts of Japan, JP 59-167949, September 9, 1984					
<i>W</i>	AW	Patent Abstracts of Japan, JP 10-214594, August 8, 1998					
	AX						
	AY						
	AZ						
Examiner <i>drf stj</i>				Date Considered 9/29/2002			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							